

Notice of References Cited	Application/Control No. 10/671,422		Applicant(s)/Patent Under Reexamination SCHMIDT ET AL.	
	Examiner Alexander S. Beck		Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,511,760	04-1985	Garwin et al.	178/18.03
*	B	US-6,121,960	09-2000	Carroll et al.	345/173
	C	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	JP 2002163073 A	06-2002	Japan	INOUE, SHUICHI	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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